Abstract

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This is the specification of the free silicon manufacturing standard for manufacturing the ls018¹ standard logic cells and related free technology nodes from the LibreSilicon project.

1 Well

Si (p-type)	We start with a p-type silicon wafer
SiO2	
Si (p-type)	We grow an oxide layer of approximately 1000 angstrom thickness (see documentation)
Resist	
SiO2	
Si (p-type)	We thin film deposit a layer of resist
	we thin thin deposit a layer of resist
SiO2	
Si (p-type)	
	We expose and develop the pattern from the GDS2 layer information
Si (p-type)	
~ (F JF)	We etch the 1000 angstrom oxide layer
N Si (p-type)	Ion implantation: Implant Phosphorus (P); n-type impurity to create N-well (see documentation)
	implimentation impliment independent (1), it type impurity to create it will (see documentation)
N	
Si (p-type)	D
N	Remove resist
Si (p-type)	
	Remove oxide

¹https://github.com/leviathanch/ls018